

Comparison of DCR Current Sense Topologies

Abstract

Current sensing plays an important role in DC/DC regulator systems, especially in multi-phase buck converters for CPU V_{CORE} applications. In V_{CORE} applications, the current signals are used to decide the load-line droop, per-phase current balance, current reporting, and over current protection. Moreover, if the control topology is current mode, the current signal will directly affect the system stability. Therefore achieving accurate current signals is very important.

Generally, the inductor DC resistance (DCR) current sensing technique is widely used in CPU voltage regulator (VR) applications due to its lossless characteristic. However, the DCR current sensing method needs to parallel an RC network beside the inductor, and is likely to be near noisy nodes like the phase node or other PWM signals. It offers many opportunities to add noise which may decrease the current sensing accuracy. In addition, the offset and bandwidth of the current sensing op amp can also decrease the sensed current signal accuracy or distort the current signal, and generally present a great challenge to acquiring a clean current signal.

In this application note, two kinds of current sense methods for multi-phase regulators will be introduced. One is the differential current sense method and the other is sum current sense method. Theoretical analysis and a comparison between these two current sense topologies will also be shown in this application note.

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1. DCR Current Sense Topology

Figure 1 shows the configuration for DCR current sensing topology. The L is the inductor and the DCR is the DC resistance of the inductor. A current sensing resistor R_x and capacitor C_x are in parallel with the inductor. Equation (3) shows the relationship between the inductor current and the V_{CX} voltage. If you only consider the DC current signal, equation (3) can be rewritten as equation (4). Considering both the DC and AC signals, equation (3) can be rewritten as equation (5). By carefully designing the time constant of R_x and C_x to satisfy the relationship $L/DCR = R_x \cdot C_x$, the pole and zero in the DCR current sensing network will coincide and cancel each other. For this reason, both the DC and AC current signals obtained from V_{CX} will be exactly same as $I_L \cdot DCR$.

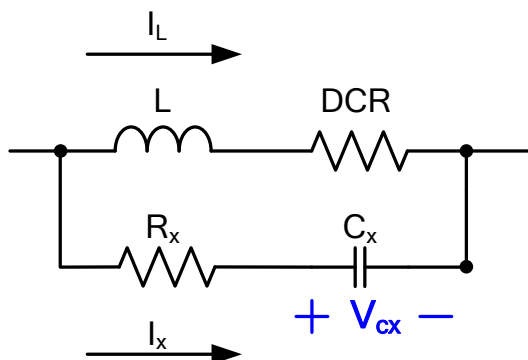


Figure 1. DCR Current Sensing Topology

$$I_L \times (s \times L + DCR) = R_x \times I_x + V_{CX} \quad (1)$$

$$I_x = s \times C_x \times V_{CX} \quad (2)$$

Substitute (2) into (1)

$$I_L \cdot (s \cdot L + DCR) = V_{CX}(1 + s \cdot R_x \cdot C_x) \quad (3)$$

Considering only the DC signal, (3) can be rewritten as (4).

$$I_L \cdot DCR = V_{CX} \quad (4)$$

From (3), considering both the DC and AC signals, (3) can be rewritten as (5):

$$I_L \cdot DCR \cdot \frac{\left(1 + s \cdot \frac{L}{DCR}\right)}{(1 + s \cdot R_x \cdot C_x)} = V_{CX} \quad (5)$$

Where K_τ is defined as $\frac{R_x \cdot C_x}{\frac{L}{DCR}}$

2. Introduction of Differential Current Sense Topology

Figure 2 shows the configuration for a differential current sensing topology. The inductor current is sensed as the voltage across the DCR current sense capacitor. Using the approximation that the op amp positive and negative input pins are a virtual short circuit, the V_{CX} voltage is duplicated on the current sensing resistor, R_{CS} , to transform the capacitor voltage V_{CX} into an internal current signal. This per-phase current signal is used to do the per-phase current balance and per-phase over current protection. Then, the per-phase currents are mirrored by the current mirror circuits respectively and summed together to form the total current signal. The total current signal is injected into the RIMON resistor network. The RIMON network is connected between the IMON pin and the VREF pin and is used to decide the load-line droop, do the sum current reporting, and provide output over current protection and DCR temperature compensation.

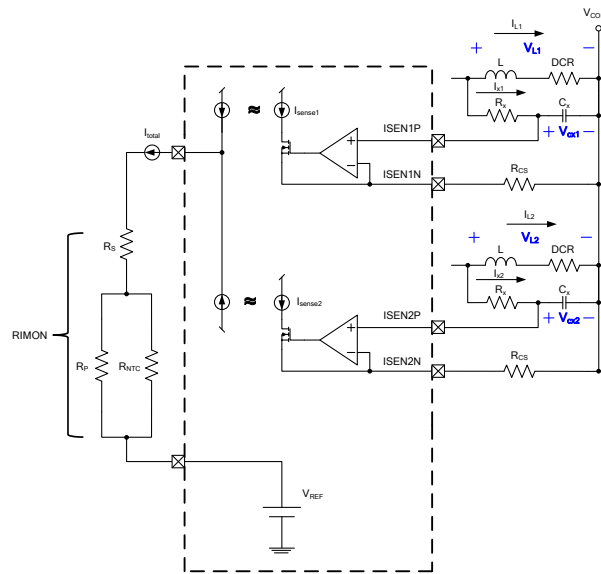


Figure 2. Differential Current Sense Topology

2.1 Derivation Procedure of Differential Current Sensing Topology

Referring to Figure 2, the voltage across the inductor (V_{L_n}) can be expressed as the inductor current (I_{L_n}) product $(DCR + s \cdot L)$. Therefore equation (6) can be rewritten as equation (7), and the capacitor current I_{X_n} can be expressed as equation (8). Substituting equation (8) into equation (7), the relationship between the inductor current and the capacitor voltage can be expressed as equation (9).

$$\begin{cases} V_{L1} = R_X \cdot I_{X1} + V_{CX1} \\ V_{L2} = R_X \cdot I_{X2} + V_{CX2} \end{cases} \quad (6)$$

$$\begin{cases} I_{L1} \cdot (s \cdot L + DCR) = R_X \cdot I_{X1} + V_{CX1} \\ I_{L2} \cdot (s \cdot L + DCR) = R_X \cdot I_{X2} + V_{CX2} \end{cases} \Rightarrow \sum_{n=1}^X I_{L_n} \cdot (s \cdot L + DCR) = \sum_{n=1}^X I_{X_n} \cdot R_X + \sum_{n=1}^X V_{CX_n} \quad (7)$$

$$\begin{cases} I_{X1} = s \cdot C_X \cdot V_{CX1} \\ I_{X2} = s \cdot C_X \cdot V_{CX2} \end{cases} \Rightarrow \sum_{n=1}^X I_{X_n} = s \cdot C_X \cdot \sum_{n=1}^X V_{CX_n} \quad (8)$$

$$\sum_{n=1}^X I_{L_n} \cdot (s \cdot L + DCR) = \sum_{n=1}^X V_{CX_n} \cdot (s \cdot C_X \cdot R_X + 1) \quad (9)$$

If the time constant of the $R_x C_x$ sensing network is matched to the inductor's L_x/DCR , equation (9) can be rewritten as equation (10). The V_{cx} voltage signals will be changed into current signals through the current sensing resistors R_{cs} , and the total sensed current can be expressed as equation (11). After that, the total sensed current is injected into the RIMON resistor network for temperature compensation. The ΔV_{IMON} voltage is sensed for total current reporting and over current protection, and to determine voltage positioning load line droop or other purposes.

$$\sum_{n=1}^x I_{Ln} \cdot DCR \cdot \frac{\left(s \cdot \frac{L}{DCR} + 1 \right)}{\left(s \cdot C_x \cdot R_x + 1 \right)} = \sum_{n=1}^x V_{cxn} \Rightarrow \sum_{n=1}^x I_{Ln} \cdot DCR = \sum_{n=1}^x V_{cxn} \quad (10)$$

$$I_{total} = \frac{\sum_{n=1}^x V_{cxn}}{R_{CS}} \quad (11)$$

$$\Delta V_{IMON} = \frac{DCR}{R_{CS}} \cdot R_{IMON} \cdot (I_{L1} + I_{L2} + \dots + I_{Ln}) \quad (12)$$

3. Introduction of Sum Current Topology

Figure. 3 shows the sum current sensing topology. The sum current sensing topology uses an op amp as an adder to sum the DCR sensing capacitor voltages (V_{cxn}). The current sensing resistors (R_{sn}) change the sensing capacitor voltages (V_{cxn}) into current signals (I_{sn}) and the total current flows to the R_{sum} resistor network (which can perform any necessary temperature compensation). The total inductor current can be obtained by sensing the V_{sum} voltage. This current sense topology needs only three pins to sense the total inductor current, which greatly reduces the number of pins compared to the differential current sense topology.

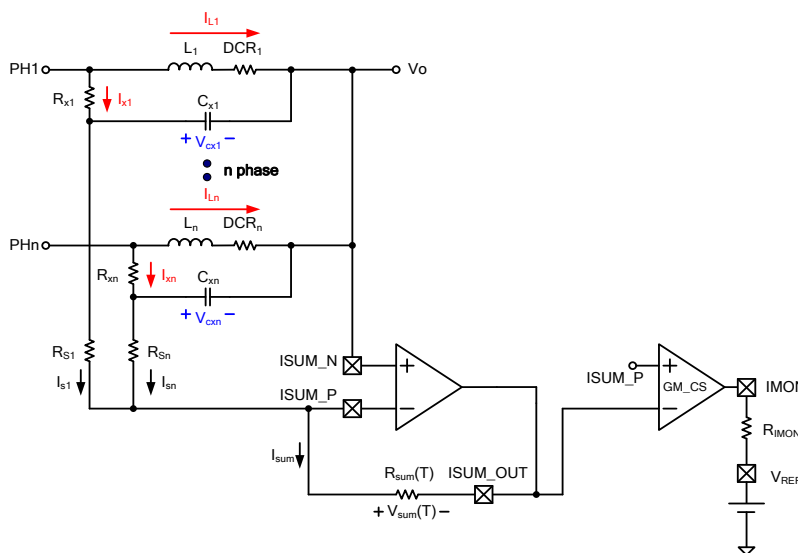


Figure 3. Sum Current Sensing Topology

To sense individual phase current signals, the sum current sensing topology needs an additional N pins for an N phase application. As Figure 4 indicates, the per-phase current signals use the common ISUM_N pin, reducing the IC pin count compared to differential sensing topologies.

In brief, the sum current sensing topology uses N+3 pins to sense both the sum current and per-phase current information. In multi-phase applications with more than 3 phases, the sum current sense topology can achieve pin savings compare to the differential current sense topology.

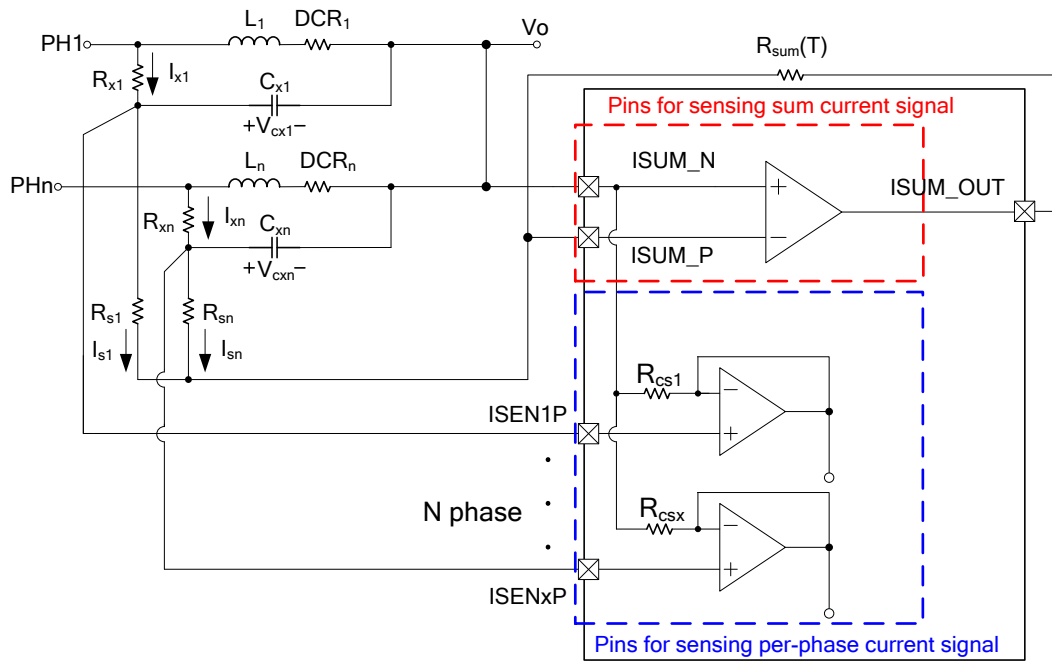


Figure 4. Per-phase Current Sense Circuit with Sum Current Topology

3.1 Derivation Procedure of Sum Current Sensing Topology

Refer to Figure. 3 and assume $L_1 = L_n = L$, $DCR_1 = DCR_n = DCR$, $R_{S1} = R_{Sn} = R_S$, for the final forms of equations (13), (14), (15) and (16). Substituting $I_{L_n} \cdot (DCR + s \cdot L)$ for V_{L_n} , the voltage across the inductor can be expressed as equation (14) and the capacitor current I_x can be expressed as equation (15). Substituting equation (15) into equation (14), the relationship between the inductor current and the capacitor voltage can be expressed as equation (16).

$$\begin{cases} V_{L1} = R_x \cdot I_{x1} + V_{cx1} \\ V_{L2} = R_x \cdot I_{x2} + V_{cx2} \end{cases} \quad (13)$$

$$\begin{cases} (s \cdot L_1 + DCR_1) \cdot I_{L1} = R_{x1} \cdot I_{x1} + V_{cx1} \\ (s \cdot L_n + DCR_n) \cdot I_{Ln} = R_{xn} \cdot I_{xn} + V_{cxn} \end{cases} \Rightarrow (s \cdot L + DCR) \cdot \sum_{i=1}^n I_{Li} = R_x \cdot \sum_{i=1}^n I_{xi} + \sum_{i=1}^n V_{cxi} \quad (14)$$

$$\begin{cases} I_{x1} = V_{cx1} / R_{S1} + s \cdot C_{x1} \cdot V_{cx1} \\ I_{xn} = V_{cxn} / R_{Sn} + s \cdot C_{xn} \cdot V_{cxn} \end{cases} \Rightarrow \sum_{i=1}^n I_{xi} = \left(\frac{1}{R_s} + s \cdot C_x \right) \cdot \sum_{i=1}^n V_{cxi} \quad (15)$$

$$\begin{cases} I_{L1} = \frac{V_{cx1}}{s \cdot L_1 + DCR} \cdot \left(1 + \frac{R_{x1}}{R_{s1}} + s \cdot C_{x1} \cdot R_{x1} \right) \\ I_{Ln} = \frac{V_{cxn}}{s \cdot L_n + DCR} \cdot \left(1 + \frac{R_{xn}}{R_{sn}} + s \cdot C_{xn} \cdot R_{xn} \right) \end{cases} \Rightarrow \sum_{i=1}^n V_{cxi} = \frac{s \cdot L + DCR}{R_x / R_s + s \cdot R_x \cdot C_x + 1} \cdot \sum_{i=1}^n I_{Li} \quad (16)$$

The V_{sum} equation can be obtained from Equation (17) and (18). After combining Equation (16) and (18), the relationship between V_{sum} and I_L can be obtained in Equation (19).

$$I_{sum} = V_{cx1} / R_{s1} + \dots + V_{csn} / R_{sn} \quad (17)$$

$$V_{sum} = R_{sum} \times I_{sum} \quad (18)$$

$$V_{sum} = \frac{DCR \times R_{sum}}{R_x + R_s} \times \frac{1 + s(L / DCR)}{1 + s(R_x // R_s)C_x} \times \sum_{i=1}^n I_{Li} \quad (19)$$

If the time constant of the $(R_x/R_s)C_x$ sensing network is matched to the inductor's L_x/DCR , equation (20) will apply and equation (19) becomes equation (21). Equation (21) shows that the V_{sum} value is proportional to the sum of the inductor currents.

$$\frac{L}{DCR} = (R_x // R_s) \times C_x \quad (20)$$

$$V_{sum} = DCR \times \frac{R_{sum}}{R_x + R_s} \times \sum_{i=1}^n I_{Li} \quad (21)$$

4. Comparison of the Differential and Sum Current Sensing Topologies

4.1 Pin Saving Capability

As mentioned above, the sum current sense topology uses an adder to sum the capacitor voltage of each DCR current sensing network. Therefore, it takes only 3 pins to get the total current information. Additionally, the sum current sense topology needs N pins to sense N per-phase current signals. Compare that to the differential current sense topology, which takes 2N pins to get N phase total current and per-phase current information. Obviously, as the phase number increases beyond 3, using the sum current sensing topology can achieve its pin saving purpose.

The differential current sensing topology can't use the single ISENN pin due to the op amp virtual short characteristic. From Figure 2, if a single ISENN pin was used, it seems like two voltage sources (ISEN1P and ISEN2P) would be connected together. If these two voltages were different, this topology would violate the KVL rule. In a realistic application the voltage of these two points may not be the same since they sense inductor current from different phases.

4.2 Per-phase Current Accuracy

Though the total current can be precisely acquired through the sum current sensing topology and the differential current sensing topology, however, the per-phase current signal is not alike. The differential current sense topology can get precise per-phase current signals because it directly senses the DCR current sense capacitor voltage. Considering the PCB parasitic inductance and resistance between the ISEN_N input pins and the load V_{CORE} point, a voltage spike will be induced at each ISEN_N pin when current passes through the parasitic elements. However, in the differential current sense topology this voltage spike will also be sensed at each ISEN_P pin and the differential value will not be affected. Figure 5 shows waveforms from a simulation, demonstrating that the sensed current remains accurate even though a voltage spike is induced at the ISEN_N pin.

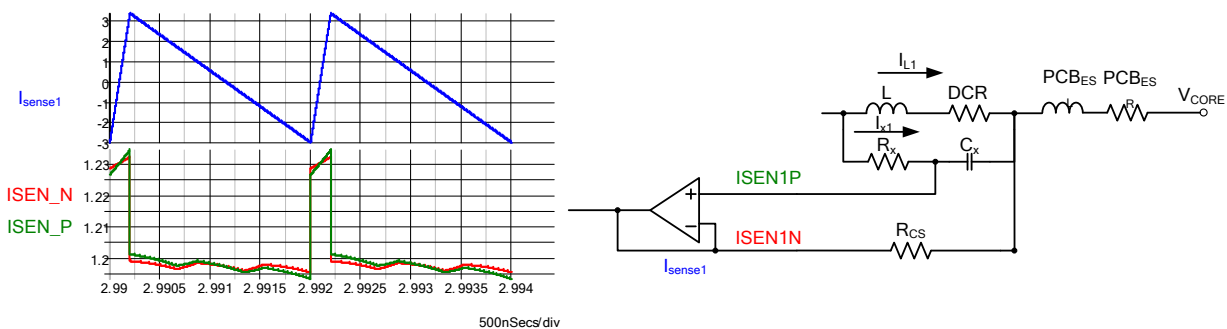


Figure 5. Parasitic Element Induced Voltage Spike at ISEN_N Pin and ISEN_P Pin

However, the sum current topology uses a common ISUM_N pin instead of per-phase ISEN_N pins to sense the per-phase current signals (Figure 3). Because the common ISUM_N pin is the average of each phase's sense capacitor negative terminal voltage, the ISUM_N voltage is slightly different from the differential topology ISEN_N point (capacitor) voltage. Especially considering the PCB parasitic inductance and resistance between the ISEN_N input pin and the load V_{CORE} point. The Figure 6 simulation waveform (a) shows the sensed per-phase current waveform with the noise induced by the unwanted PCB parasitic parameters. Therefore, the per-phase current accuracy of the sum current sense topology may not be as good as the differential current sense topology.

However, some well-placed filter components can improve the performance of the sum topology. The filter components R_F and C_F can be added at each sense capacitor negative terminal, decoupling it from the output load point. This increases the layout complexity of the sum current sensing topology but significantly improves its per-phase accuracy. The Figure 6 simulation waveform (b) shows the sensed per-phase current waveform with the R_F and C_F filter components on each phase as shown in the circuit drawing.

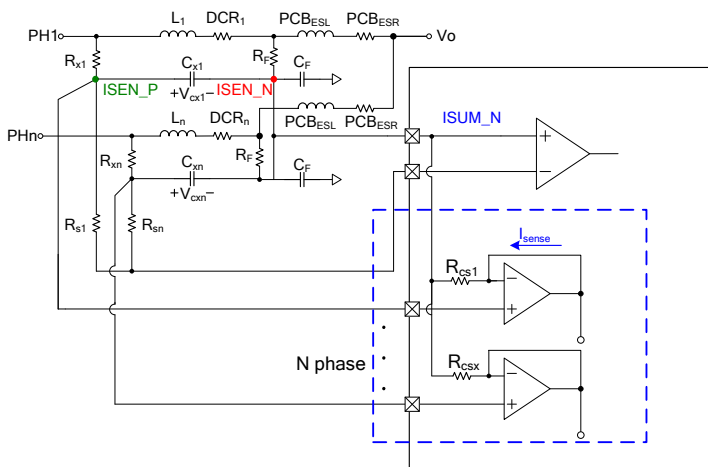
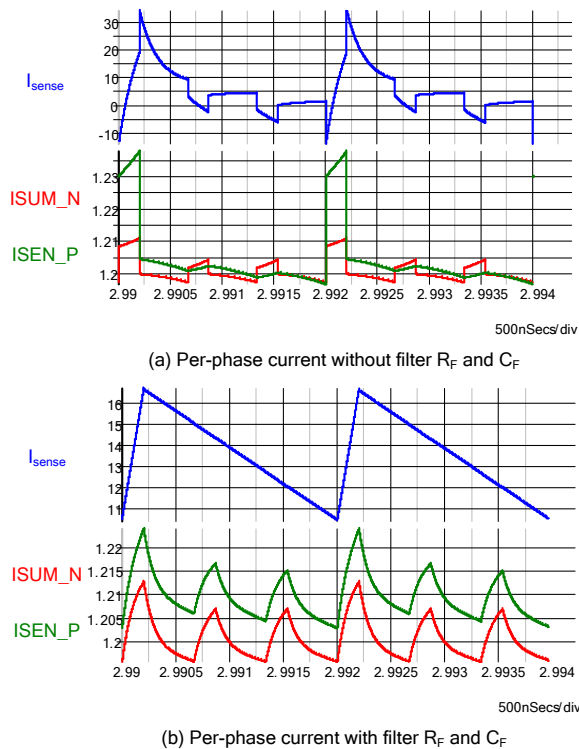


Figure 6. Sum Current Sense Topology with Parasitic Parameters

4.3 Tolerance of Band (TOB) Analysis and Commercial Grade Temperature Specification

TOB Analysis:

The differential current sense method needs N current sensing op amps to convert the V_{CX} voltage signals into current signals. Due to wafer process variations, the characteristics of each current sensing op amp may be different, such as input offset voltage, input bias current ...etc. The offset voltage of the current sensing op amp may let the controller false detect the current level and regulate at the wrong voltage position, thereby lowering the output voltage and current reporting accuracy. To avoid this phenomenon, a self-calibration function is implemented in the IC during the IC start up procedure. Since the differential current sense method needs to calibrate N current sensing op amps, it is hard to increase the calibration resolution in the same IC die size. Therefore, the differential current sense method might have a larger offset voltage and need a tighter tolerance band to cover this issue.

However, in the sum current sense topology, there is only one current sense op amp in the total current signal path. Because only one op amp needs to be calibrated, the self-calibration resolution can be increased in the same IC die size, to reduce the op amp offset voltage. In the sum current topology the per-phase current signal, which is only used for current balance and per-phase over current protection, is not directly used to decide the output voltage positioning. Therefore, the TOB of the per-phase current sense op amp can be loosened and the slight mismatch between per-phase current sensing op amps is acceptable.

Commercial Grade Temperature Specification

Since the sum current sensing topology can use a higher self-calibration resolution to minimize the op amp input offset voltage, a wider operation temperature range can be adopted. Therefore, the sum current sensing topology can more easily pass the commercial grade temperature specification.

Table 1. Comparison of Differential and Sum Current Sensing Topologies

	Differential Current Sensing Topology	Sum Current Sensing Topology
IC Pin Count	Phase Number < 3 Better	Phase Number > 3 Better
Sum current accuracy		Better
Per-phase current accuracy	Better	
PCB _{ESR} and PCB _{ESL} voltage spike noise immunity	Better	
PCB layout complexity	Simple	Complex
Wafer process variation immunity		Better
Commercial Grade Temperature and TOB spec		Easier to pass

5. Design Approach of Differential and Sum Current Topologies

The following design example will use the RT8884 for the differential current sense topology, and the RT8893 for the sum current sense topology. Both of these two ICs are designed to meet the Intel VR12.5 specification.

VCORE Specification	
Input Voltage	10.8V to 13.2V
No. of Phases	3
Vboot	1.7V
VDAC(MAX)	1.8V
ICCMAX	90A
ICC-DY	60A
ICC-TDC	55A
Load Line	1.5m Ω
Fast Slew Rate	12.5mV/ μ s
Max Switching Frequency	300kHz

In Intel's Shark Bay VRTB Guideline, the output filter requirements of the specification for a desktop platform are as follows:

Output Inductor: 360nH/0.72m Ω

Output Bulk Capacitor: 560 μ F/2.5V/5m Ω (max) 4 to 5pcs

Output Ceramic Capacitor: 22 μ F/0805 (18pcs max sites on top side)

Step 1 : Determine the Parameters of the Inductors

Output Inductor: 360nH/0.72m Ω

Step 2 : Determine the DCR Current Sensing Network Parameters

Choose the DCR current sensing capacitor (C_X) value.

$$C_X = 1\mu\text{F}$$

From experimental experience, using a 0.1 μ F capacitor the current sensing accuracy will degenerate at low current condition, so a 1 μ F capacitor is chosen.

Determine the DCR network time constant ratio, k_τ .

If the DCR network time constant ratio is less than 1, the capacitive time constant is less than the inductive time constant. This causes the AC current sense gain to be greater than the DC gain, increasing the DCR current sensing capacitor voltage (V_{CX}) during the transient period. This causes voltage positioning overshoot and under shoot on load transients, and increases the

possibility of incorrectly hitting the current limit. A ratio greater than 1 reduces sensed inductor ripple and transient current changes and will cause a sluggish voltage droop, but excessively small sensed inductor ripple can affect loop stability. Therefore, the DCR network time constant ratio is suggested to be equal to or slightly larger than 1. In this design example, the time constant ratio, k_τ , is chosen as 1. Figure 7 shows the simulation waveform during load transients. Three different DCR current sensing time constant ratio, 0.8, 1, 1.2, are used in the simulation to show the influence of K_τ on the output voltage positioning and sensed current.

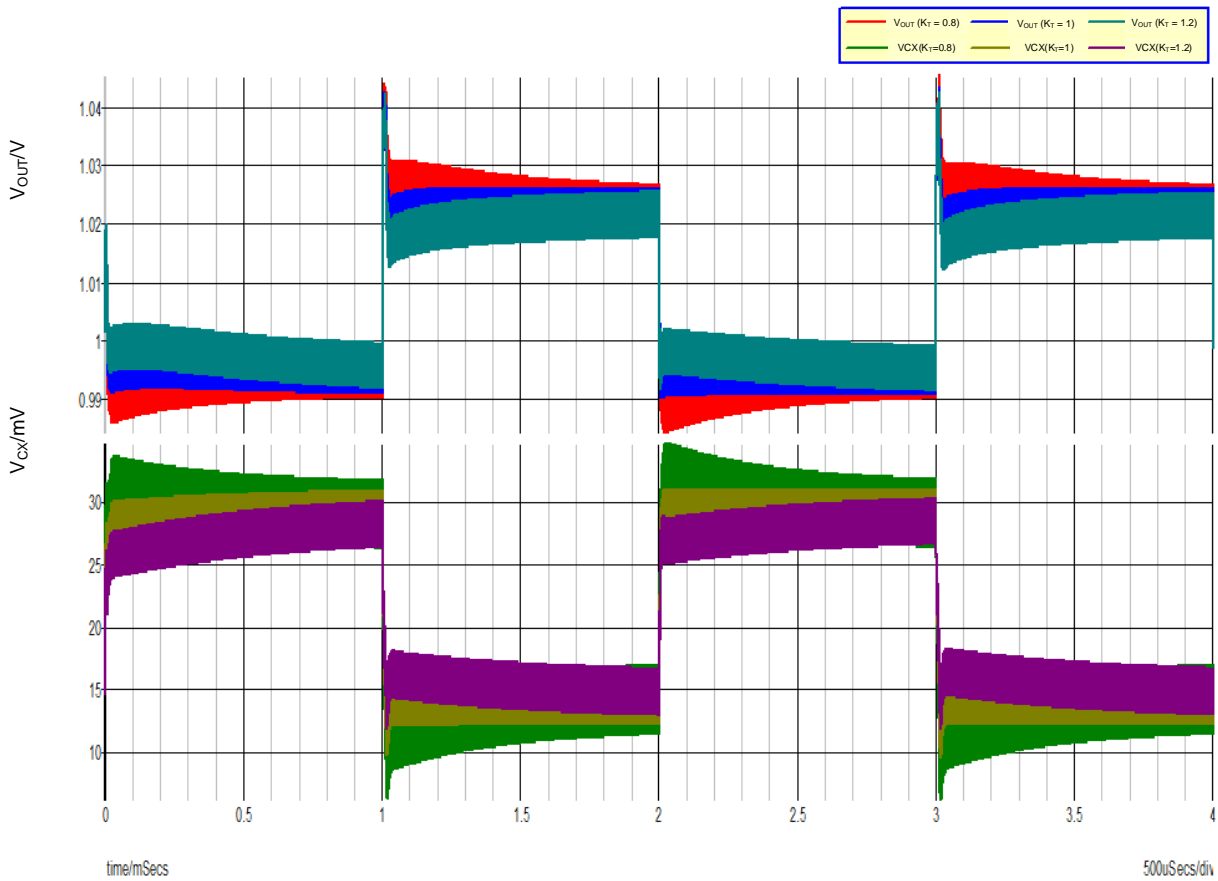


Figure 7 Output Voltage (V_{OUT}) and V_{cX} Voltage Load Transient Response with Various K_τ Values

Differential current sense:

$$\frac{L}{DCR} \cdot k_\tau = R_X \cdot C_X \quad (22)$$

Sum current sense:

$$\frac{L}{DCR} \cdot k_\tau = \frac{R_X \cdot R_S}{R_X + R_S} \cdot C_X \quad (23)$$

Step3: Calculate the R_X and R_S Values

Determine the R_X and R_S resistance values.

Differential current sense:

$$R_X = \frac{L}{DCR} \cdot k_r = 0.5 \text{ (k}\Omega\text{)} \quad (24)$$

Sum current sense:

For sum current sensing op amp stability considerations, the ratio between R_{sum} and $(R_X + R_S)$ is suggested to be 4, and the R_{sum} value is suggested between $4k\Omega \sim 16k\Omega$. For the RT8893 application we choose $R_{sum} = 16k\Omega$ and the total resistance of $(R_X + R_S)$ is therefore $4k\Omega$. Note, high resistance values reduce “the sum current sensing op amp phase margin. (For example: if $(R_X + R_S) = 4k\Omega$ and $R_{sum} = 16k\Omega$, the sum op amp phase margin is about 45°).

$$R_X + R_S = \frac{R_{sum}}{4} = \frac{16k}{4} = 4k \quad (25)$$

Using equation (23), the $R_X \cdot R_S$ product value can be calculated.

$$\frac{L}{DCR} \cdot k_r = \frac{R_X \cdot R_S}{R_X + R_S} \cdot C_X \Rightarrow R_X \cdot R_S = \frac{L}{DCR} \cdot k_r \cdot \frac{(R_X + R_S)}{C_X} \quad (26)$$

From (25) and (26), equation (27) can be used to find the R_X and R_S value. Substitute R_X into $R_X \cdot R_S$, a R_S second order equation can be derived. Substitute above mentioned parameter value into this equation and the R_S can be found as $3.41k\Omega$ and R_X as $0.59k\Omega$.

$$\begin{cases} R_X + R_S = \frac{R_{sum}}{4} \Rightarrow R_X = \frac{R_{sum}}{4} - R_S \\ R_X \cdot R_S = \frac{L}{DCR} \cdot k_r \cdot \frac{(R_X + R_S)}{C_X} \end{cases} \quad (27)$$

$$\begin{aligned} \Rightarrow \left(\frac{R_{sum}}{4} - R_S \right) \cdot R_S &= \frac{L}{DCR} \cdot k_r \cdot \frac{(R_X + R_S)}{C_X} \\ \Rightarrow R_S^2 - \frac{R_{sum}}{4} \cdot R_S + \frac{L}{DCR} \cdot k_r \cdot \frac{(R_X + R_S)}{C_X} &= 0 \end{aligned}$$

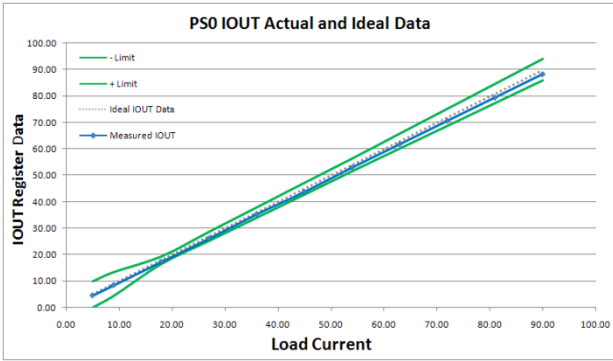
$$\Rightarrow R_S = \frac{\frac{R_{sum}}{4} + \sqrt{\frac{R_{sum}^2}{4} - 4 \cdot \frac{L}{DCR} \cdot k_r \cdot \frac{(R_X + R_S)}{C_X}}}{2}$$

$$\Rightarrow R_S = 3.41 \text{ (k}\Omega\text{)}$$

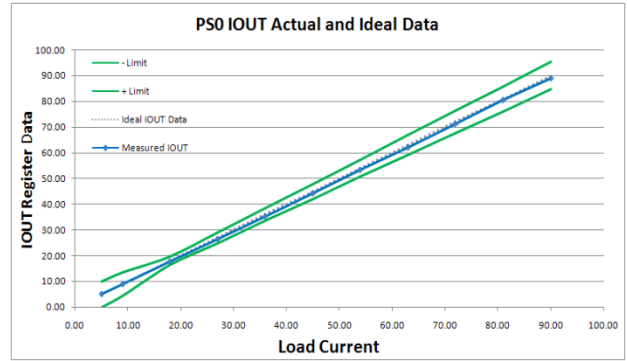
$$\Rightarrow R_X = (R_X + R_S) - R_S = 0.59 \text{ (k}\Omega\text{)}$$

6. Experimental Result

In a realistic application, the CPU will ask the VR to report the loading status. Therefore, the VR will change the sensed analog current signal into hexadecimal digital code, so-called as digital IMON (DIMON). If the DIMON is exactly the same as the loading current, we can judge that the VR can accurately sense the loading current. Figure 8 shows the DIMON current sense result using the two different current sense topologies. The dotted line is the ideal loading current signal, and the solid line is the reporting DIMON result. From the experimental results, both the sum current sense topology and differential current sense topology can deliver accurate total inductor current information.



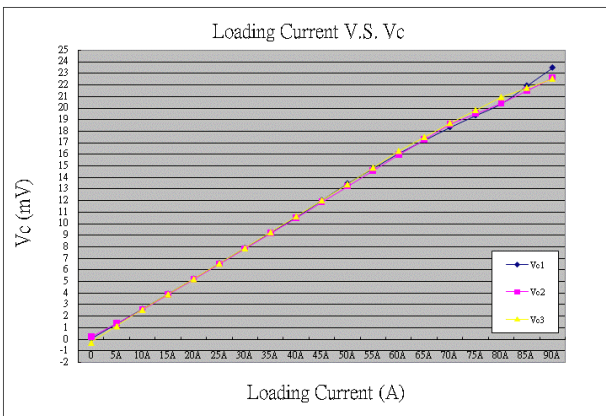
(a) RT8884 differential current sense topology



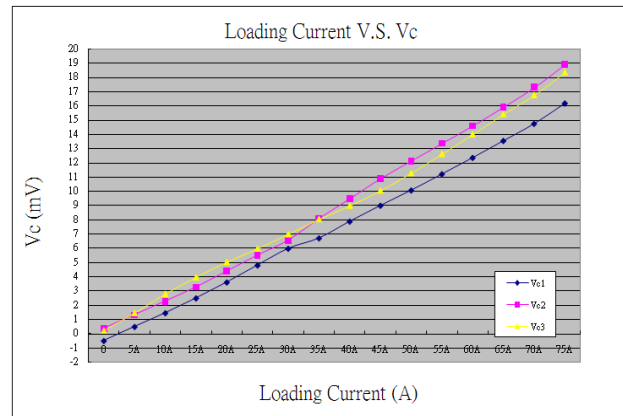
(b) RT8893 sum current sense topology

Figure 8. DIMON current sense using two different current sense topologies

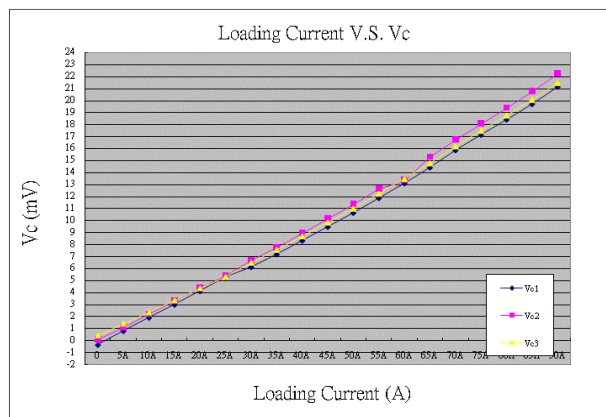
Figure 9 (a) shows the measured per-phase current sense signals with differential current sensing topologies, which shows that the differential current sensing topology features good per-phase current accuracy. Plot (b) shows the sum current sensing topology without the filter components. Since the sum current topology uses a common ISUM_N pin instead of directly sensing the negative terminal of the DCR capacitor, the per-phase current is not as accurate as the differential current sense topology. Plot (c) shows the sum current sensing topology with the filter components included. From the experimental result, the filter components can greatly improve the per-phase current accuracy, but is still inferior to differential sensing.



(a) RT8884 differential current sense topology



(b) RT8893 sum current sense topology w/o filter component



(c) RT8893 sum current sense topology with the filter component

Figure 9. Per-phase Current Signal with Various Current Sense Topologies

7. Conclusion

This application note discussed two different kinds of current sense methods for multi-phase regulators. The sum current sense topology features better sum current accuracy, lower IC pin count, and more easily passes the TOB specifications. The differential current sense topology features better per-phase current accuracy and higher parasitic ESR and ESL noise immunity. In choosing a current sense topology, take into consideration your realistic application conditions, to find the most suitable current sense solution.

8. Reference

[1] Richtek, RT8884B datasheet.

[2] Richtek, RT8893A datasheet.

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